Searcn Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/634,383	DESMARAIS, CHRISTOPHE P.		
Examiner	Art Unit		
Yoon-Young Kim	1723		

	SEAR	CHED	
Class	Subclass	Date	Examiner
	·		
<u>-</u>			-

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH (INCLUDING SEAR	NOTES CH STRATEGY)
	DATE	EXMR
See EAST Search History	1/27/2006	YK
		-
	_	